## Notice of References Cited Application/Control No. 10/784,817 Examiner THOMAS D. ALUNKAL Applicant(s)/Patent Under Reexamination PARK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0076096	04-2004	Hwang et al.	369/053.21
*	В	US-6,581,167	06-2003	Gotoh et al.	714/7
*	С	US-5,914,928	06-1999	Takahashi, Hideki	369/47.14
*	D	US-2001/0026511	10-2001	Ueda et al.	369/47.14
*	Е	US-6,160,778	12-2000	Ito et al.	369/53.15
*	F	US-6,606,285	08-2003	Ijtsma et al.	369/47.1
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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